

## N-Channel Logic Level Enhancement Mode Field Effect Transistor

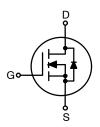
## **BSS123**

#### **General Description**

These N-Channel enhancement mode field effect transistors are produced using **onsemi's** proprietary, high cell density, DMOS technology. These products have been designed to minimize on-state resistance while provide rugged, reliable, and fast switching performance. These products are particularly suited for low voltage, low current applications such as small servo motor control, power MOSFET gate drivers, and other switching applications.

#### **Features**

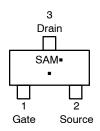
- 0.17 A, 100 V
  - $R_{DS(on)} = 6 \Omega @ V_{GS} = 10 V$
  - $R_{DS(on)} = 10 \Omega @ V_{GS} = 4.5 V$
- High Density Cell Design for Extremely Low R<sub>DS(on)</sub>
- Rugged and Reliable
- Compact Industry Standard SOT-23 Surface Mount Package
- This Device is Pb-Free and Halogen Free





SOT-23-3 CASE 318-08

#### **MARKING DIAGRAM**



SA = Specific Device Code

M = Date Code\*= Pb-Free Package

(Note: Microdot may be in either location)

\*Date Code orientation and/or position may vary depending upon manufacturing location.

#### **ORDERING INFORMATION**

Device	Package	Shipping <sup>†</sup>
BSS123,	SOT-23-3	3000 /
BSS123-G	(Pb-Free)	Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

#### **BSS123**

### ABSOLUTE MAXIMUM RATINGS $T_A$ = $25^{\circ}C$ unless otherwise noted.

Symbol	Parameter	Ratings	Unit
V <sub>DSS</sub>	Drain-Source Voltage	100	V
V <sub>GSS</sub>	Gate-Source Voltage	±20	
I <sub>D</sub>	Drain Current – Continuous (Note 1)	0.17	Α
	Drain Current – Pulsed (Note 1)	0.68	
P <sub>D</sub>	Maximum Power Dissipation (Note 1)	0.36	W
	Derate Above 25°C	2.8	mW/°C
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Junction Temperature Range	−55 to +150	°C
T <sub>L</sub>	Maximum Lead Temperature for Soldering Purposes, 1/16" from Case for 10 s	300	

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

## THERMAL CHARACTERISTICS $T_A = 25^{\circ}C$ unless otherwise noted.

Symbol	Parameter	Ratings	Unit
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient (Note 1)	350	°C/W

### **ELECTRICAL CHARACTERISTICS** $T_A = 25^{\circ}C$ unless otherwise noted.

Symbol	Parameter	Test Conditions	Min	Тур	Max	Unit
OFF CHARA	CTERISTICS		•		•	
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	100	-	_	V
$\frac{\Delta BV_{DSS}}{\Delta T_{J}}$	Breakdown Voltage Temperature Coefficient	$I_D$ = 250 μA, Referenced to 25°C	_	97	-	mV/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> = 100 V, V <sub>GS</sub> = 0 V	-	-	1	μΑ
		$V_{DS} = 100 \text{ V}, V_{GS} = 0 \text{ V}, $ $T_{J} = 125^{\circ}\text{C}$	_	-	60	
		V <sub>DS</sub> = 20 V, V <sub>GS</sub> = 0 V	-	-	10	nA
I <sub>GSS</sub>	Gate-Body Leakage	V <sub>GS</sub> = ±20 V, V <sub>DS</sub> = 0 V	-	-	±50	nA
ON CHARAC	TERISTICS (Note 2)	•	•		-	
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{DS} = V_{GS}$ , $I_D = 1 \text{ mA}$	0.8	1.7	2	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate Threshold Voltage Temperature Coefficient	I <sub>D</sub> = 1 mA, Referenced to 25°C	_	-2.7	-	mV/°C
R <sub>DS(on)</sub>	Static Drain-Source On-Resistance	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 0.17 A	-	1.2	6	Ω
		V <sub>GS</sub> = 4.5 V, I <sub>D</sub> = 0.17 A	-	1.3	10	
		$V_{GS} = 10 \text{ V, } I_D = 0.17 \text{ A,} $ $T_J = 125^{\circ}\text{C}$	_	2.2	12	
I <sub>D(on)</sub>	On-State Drain Current	V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 5 V	0.68	-	_	Α
9FS	Forward Transconductance	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 0.17 A	0.08	0.8	-	S
DYNAMIC CH	HARACTERISTICS	•	•	•	•	
C <sub>iss</sub>	Input Capacitance	$V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V},$	_	73	_	pF
C <sub>oss</sub>	Output Capacitance	f = 1.0 MHz	-	7	_	
C <sub>rss</sub>	Reverse Transfer Capacitance	7	-	3.4	_	
$R_{G}$	Gate Resistance	V <sub>GS</sub> = 15 mV, f = 1.0 MHz	-	2.2	-	Ω

#### **ELECTRICAL CHARACTERISTICS** T<sub>A</sub> = 25°C unless otherwise noted. (continued)

Symbol	Parameter	Test Conditions	Min	Тур	Max	Unit
WITCHING	CHARACTERISTICS (Note 2)		-			
t <sub>d(on)</sub>	Turn-On Delay Time	$V_{DD} = 30 \text{ V}, I_{D} = 0.28 \text{ A}, V_{GS} = 10 \text{ V}, R_{GEN} = 6 \Omega$	-	1.7	3.4	ns
t <sub>r</sub>	Turn-On Rise Time	$V_{GS} = 10 \text{ V, H}_{GEN} = 6 \Omega$	-	9	18	
t <sub>d(off)</sub>	Turn-Off Delay Time		-	17	31	
t <sub>f</sub>	Turn-Off Fall Time		-	2.4	5	
Qg	Total Gate Charge	$V_{DS} = 30 \text{ V}, I_D = 0.22 \text{ A},$	-	1.8	2.5	nC
Q <sub>gs</sub>	Gate-Source Charge	V <sub>GS</sub> = 10 V	-	0.2	-	
Q <sub>gd</sub>	Gate-Drain Charge		_	0.3	_	

$I_S$	Maximum Continuous Drain-Source Diode Forward Current			_	0.17	Α
$V_{SD}$	Drain–Source Diode Forward Voltage $V_{GS} = 0 \text{ V}, I_S = 0.44 \text{ A} \text{ (Note 2)}$		-	0.8	1.3	V
t <sub>rr</sub>	Diode Reverse Recovery Time	$I_F = 0.17 \text{ A}, d_{if}/d_t = 100 \text{ A}/\mu\text{s}$	-	11	-	ns
Q <sub>rr</sub>	Diode Reverse Recovery Charge		-	3	_	nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

- 1.  $R_{\theta JA}$  is the sum of the junction–to–case and case–to–ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins.  $R_{\theta JA}$  is guaranteed by design while  $R_{\theta JA}$  is determined by the user's board design.
  - a) 350°C/W when mounted on a minimum pad.

2. Pulse Test: Pulse Width  $\leq$  300  $\mu\text{s},$  Duty Cycle  $\leq$  2.0%

#### **TYPICAL CHARACTERISTICS**

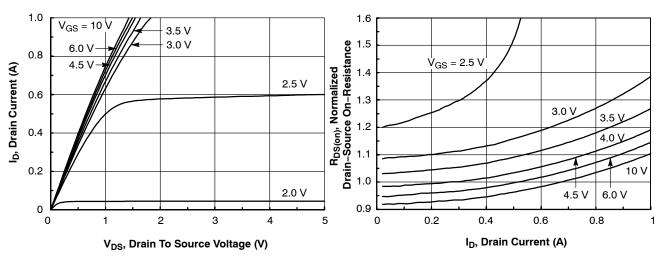
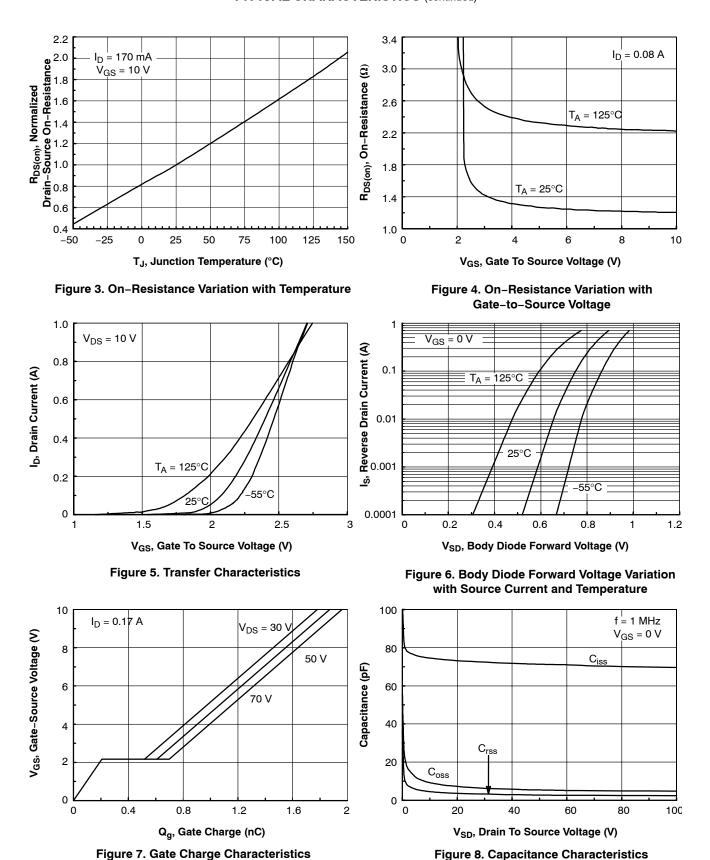


Figure 1. On-Region Characteristics

Figure 2. On-Resistance Variation with Drain Current and Gate Voltage

#### TYPICAL CHARACTERISTICS (continued)



#### TYPICAL CHARACTERISTICS (continued)

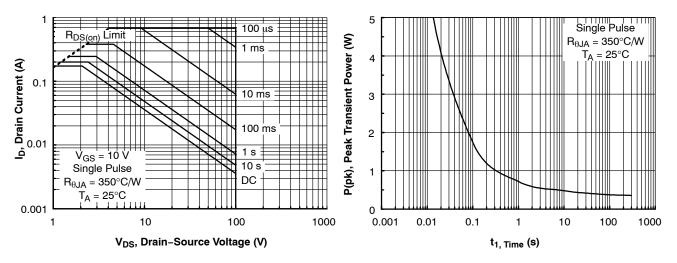


Figure 9. Maximum Safe Operating Area

Figure 10. Single Pulse Maximum Power Dissipation

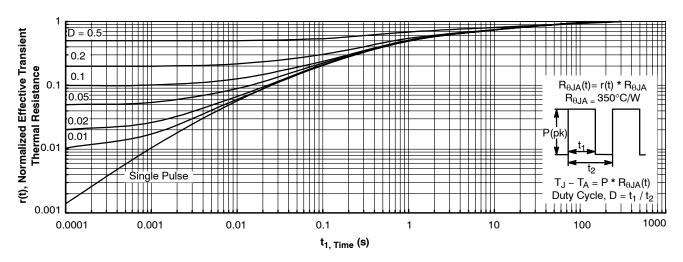


Figure 11. Transient Thermal Response Curve

Thermal characterization performed using the conditions described in Note 1a. Transient thermal response will change depending on the circuit board design.





**SOT-23 (TO-236)** CASE 318 ISSUE AT

**DATE 01 MAR 2023** 









#### NOTES:

- DIMENSIONING AND TOLERANCING PER ASME Y14.5M,1994.
- 2. CONTROLLING DIMENSION: MILLIMETERS
- 3. MAXIMUM LEAD THICKNESS INCLUDES LEAD FINISH. MINIMUM LEAD THICKNESS IS THE MINIMUM THICKNESS OF THE BASE MATERIAL.
- 4. DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR GATE BURRS.

	MILLIM	IETERS		INCHES		
DIM	MIN.	N□M.	MAX.	MIN.	N□M.	MAX.
Α	0.89	1.00	1.11	0.035	0.039	0.044
A1	0.01	0.06	0.10	0.000	0.002	0.004
b	0.37	0.44	0.50	0.015	0.017	0.020
С	0.08	0.14	0.20	0.003	0.006	0.008
D	2.80	2.90	3.04	0.110	0.114	0.120
Ε	1.20	1.30	1.40	0.047	0.051	0.055
e	1.78	1.90	2.04	0.070	0.075	0.080
L	0.30	0.43	0.55	0.012	0.017	0.022
L1	0.35	0.54	0.69	0.014	0.021	0.027
HE	2.10	2.40	2.64	0.083	0.094	0.104
Т	0*		10°	0*		10°

## GENERIC MARKING DIAGRAM\*



XXX = Specific Device Code

M = Date Code

■ = Pb-Free Package



RECOMMENDED MOUNTING FOOTPRINT

For additional information on our Pb-Free strategy and soldering details, please download the DN Semiconductor Soldering and Mounting Techniques Reference Manual, SDLDERRM/D.

#### **STYLES ON PAGE 2**

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<sup>\*</sup>This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "•", may or may not be present. Some products may not follow the Generic Marking.

# MECHANICAL CASE OUTLINE PACKAGE DIMENSIONS



#### **SOT-23 (TO-236)** CASE 318 ISSUE AT

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STYLE 1 THRU 5: CANCELLED	STYLE 6: PIN 1. BASE 2. EMITTER 3. COLLECTOR	STYLE 7: PIN 1. EMITTER 2. BASE 3. COLLECTOR	STYLE 8: PIN 1. ANODE 2. NO CONNECTION 3. CATHODE	1	
STYLE 9: PIN 1. ANODE 2. ANODE 3. CATHODE	STYLE 10: PIN 1. DRAIN 2. SOURCE 3. GATE	STYLE 11: PIN 1. ANODE 2. CATHODE 3. CATHODE-ANODE	STYLE 12: PIN 1. CATHODE 2. CATHODE 3. ANODE	STYLE 13: PIN 1. SOURCE 2. DRAIN 3. GATE	STYLE 14: PIN 1. CATHODE 2. GATE 3. ANODE
STYLE 15: PIN 1. GATE 2. CATHODE 3. ANODE	STYLE 16: PIN 1. ANODE 2. CATHODE 3. CATHODE	STYLE 17: PIN 1. NO CONNECTION 2. ANODE 3. CATHODE	STYLE 18: PIN 1. NO CONNECTION 2. CATHODE 3. ANODE	STYLE 19: N PIN 1. CATHODE 2. ANODE 3. CATHODE-ANODE	STYLE 20: PIN 1. CATHODE 2. ANODE 3. GATE
STYLE 21: PIN 1. GATE 2. SOURCE 3. DRAIN	STYLE 22: PIN 1. RETURN 2. OUTPUT 3. INPUT	STYLE 23: PIN 1. ANODE 2. ANODE 3. CATHODE	STYLE 24: PIN 1. GATE 2. DRAIN 3. SOURCE	STYLE 25: PIN 1. ANODE 2. CATHODE 3. GATE	STYLE 26: PIN 1. CATHODE 2. ANODE 3. NO CONNECTION
STYLE 27: PIN 1. CATHODE 2. CATHODE 3. CATHODE	STYLE 28: PIN 1. ANODE 2. ANODE 3. ANODE				

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